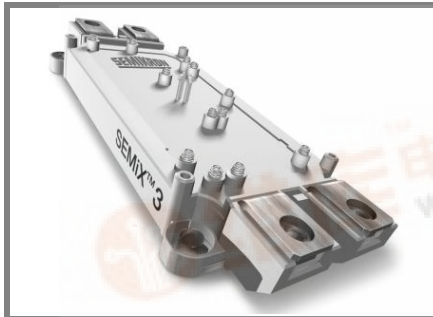


SEMIX 653GB176HDS



SEMIX® 3s

Trench IGBT Modules

SEMIX 653GB176HDS

Preliminary Data

Features

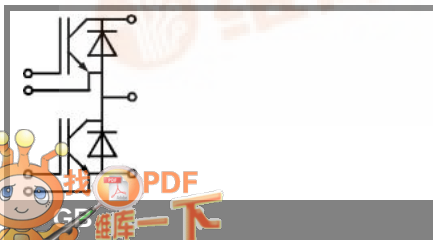
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- Released for Sn-Pb and Ni-Au PCB surfaces

Typical Applications

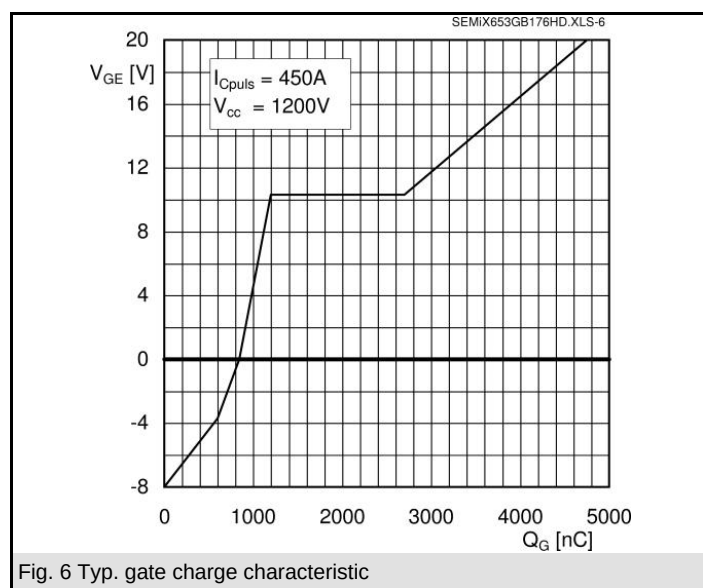
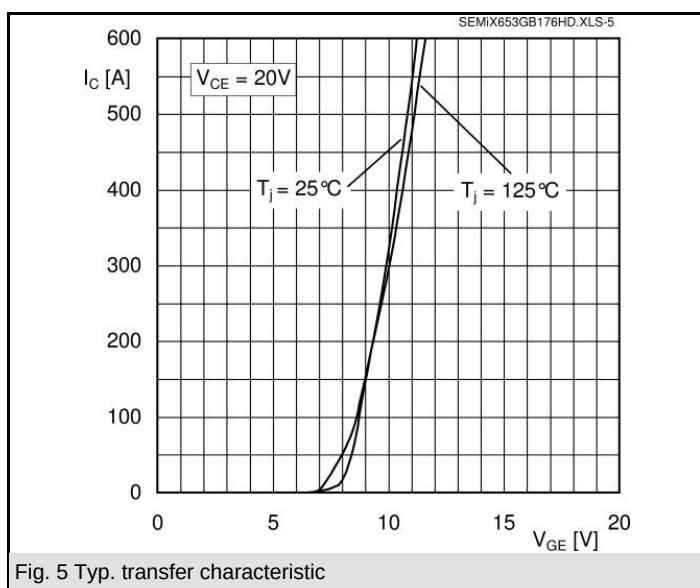
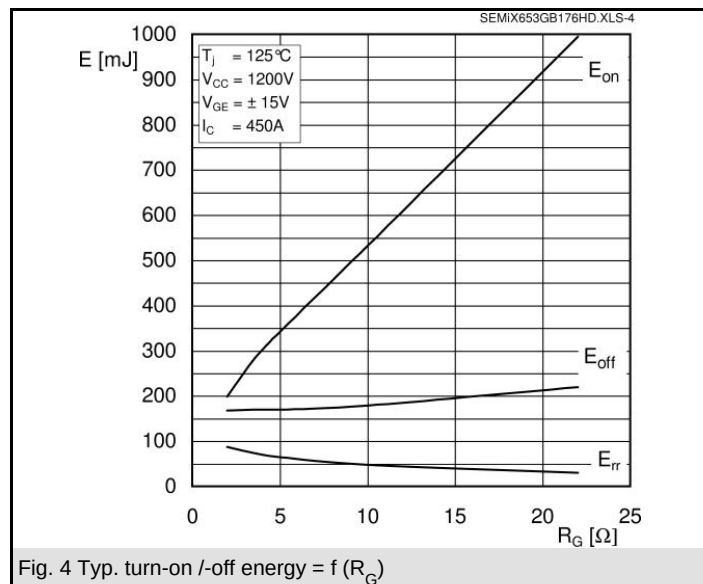
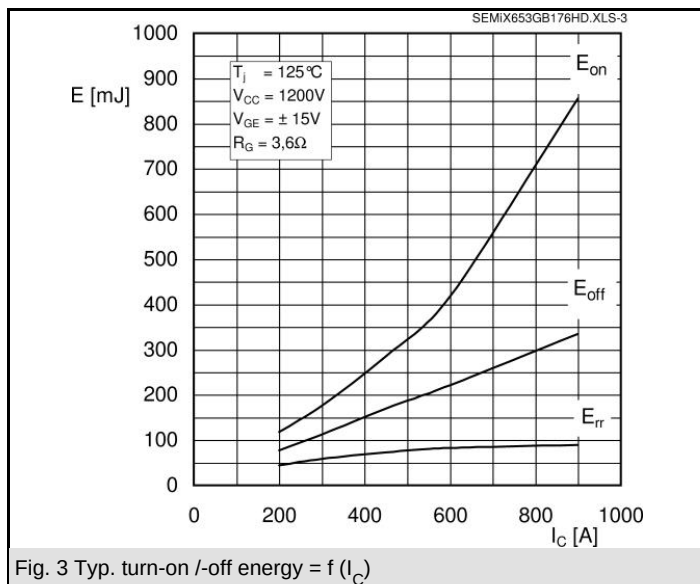
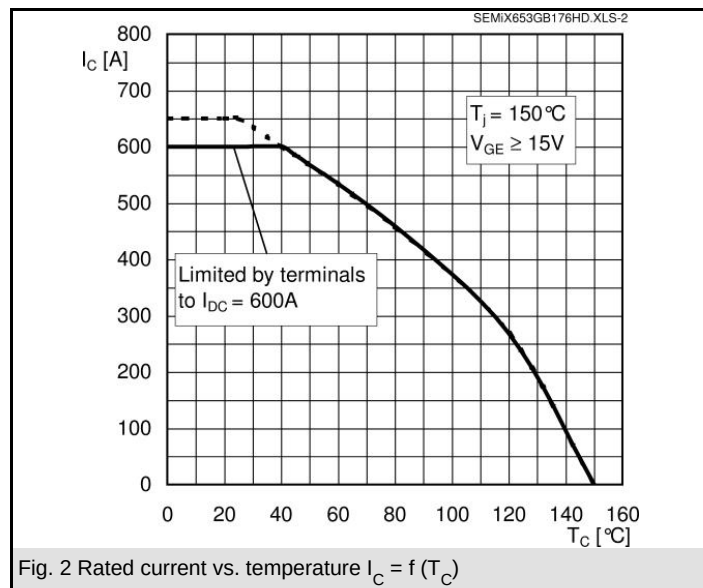
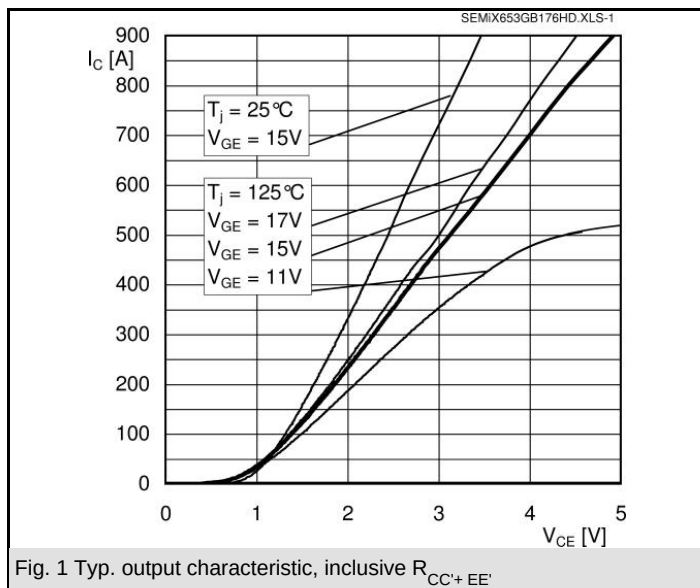
- AC inverter drives
- UPS
- Electronic welders

Absolute Maximum Ratings		$T_c = 25\text{ }^\circ\text{C}$, unless otherwise specified	
Symbol	Conditions	Values	Units
IGBT			
V_{CES}		1700	V
I_C	$T_c = 25\text{ (80) }^\circ\text{C}$	650 (460)	A
I_{CRM}	$t_p = 1\text{ ms}$	900	A
V_{GES}		± 20	V
T_{vj} , (T_{stg})	$T_{OPERATION} \leq T_{stg}$	- 40 ... + 150 (125)	$^\circ\text{C}$
V_{isol}	AC, 1 min.	4000	V
Inverse diode			
I_F	$T_c = 25\text{ (80) }^\circ\text{C}$	500 (340)	A
I_{FRM}	$t_p = 1\text{ ms}$	900	A
I_{FSM}	$t_p = 10\text{ ms}$; sin.; $T_j = 150\text{ }^\circ\text{C}$	2900	A

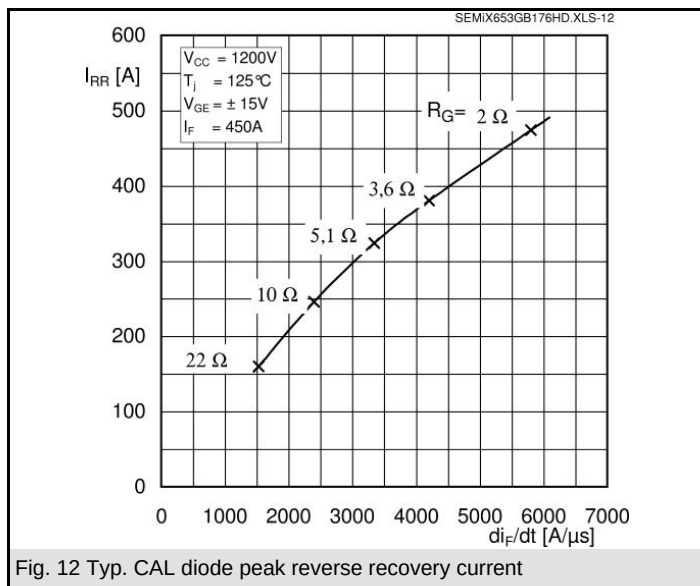
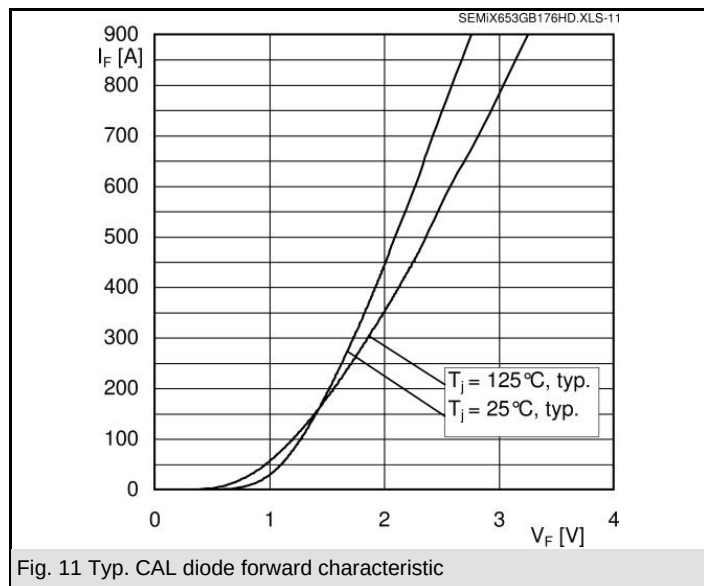
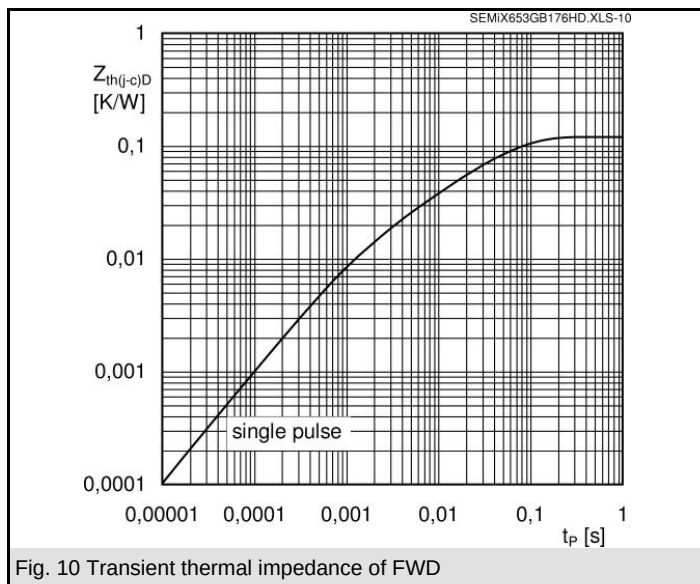
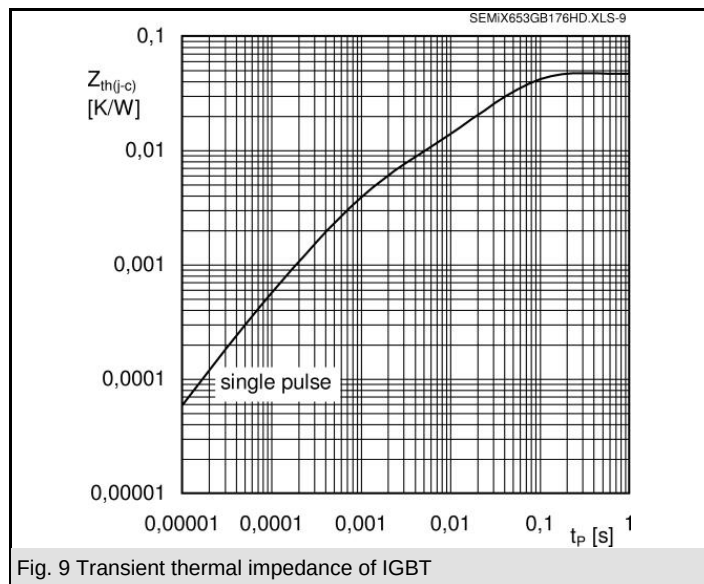
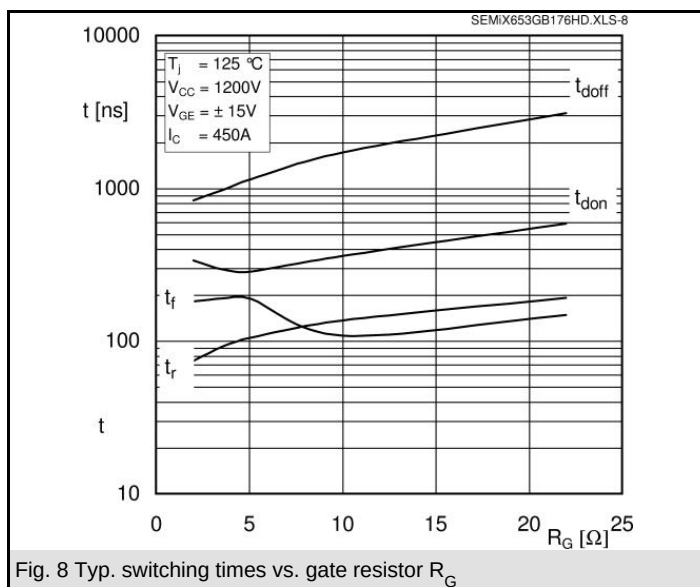
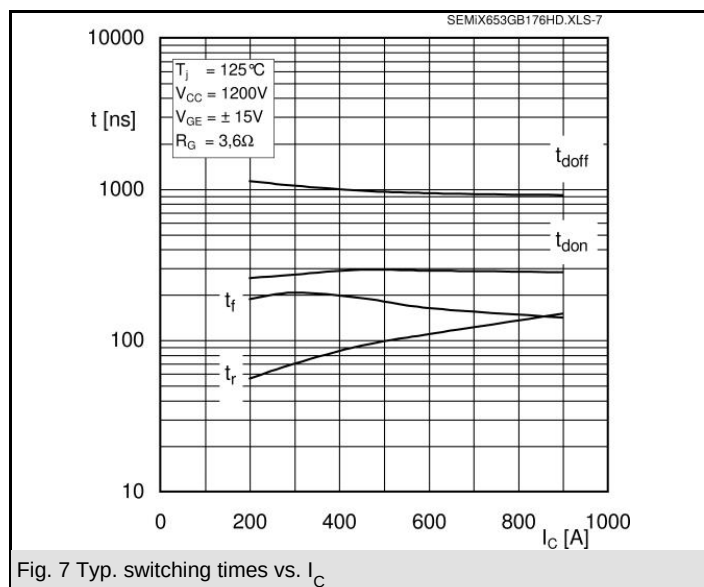
Characteristics		$T_c = 25\text{ }^\circ\text{C}$, unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
IGBT					
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 18\text{ mA}$	5,2	5,8	6,4	V
I_{CES}	$V_{GE} = 0$, $V_{CE} = V_{CES}$, $T_j = 25\text{ () }^\circ\text{C}$			0,45	mA
$V_{CE(TO)}$	$T_j = 25\text{ (125) }^\circ\text{C}$		1 (0,9)	1,2 (1,1)	V
r_{CE}	$V_{GE} = 0\text{ V}$, $T_j = 25\text{ (125) }^\circ\text{C}$		2,2 (3,4)	2,8 (4)	m Ω
$V_{CE(sat)}$	$I_{Cnom} = 450\text{ A}$, $V_{GE} = 15\text{ V}$, $T_j = 25\text{ (125) }^\circ\text{C}$, chip level		2 (2,45)	2,45 (2,9)	V
C_{ies}	under following conditions		40		nF
C_{oes}	$V_{GE} = 0$, $V_{CE} = 25\text{ V}$, $f = 1\text{ MHz}$		1,7		nF
C_{res}			1,3		nF
L_{CE}			20		nH
R_{CC+EE}	terminal-chip, $T_c = 25\text{ (125) }^\circ\text{C}$		0,7 (1)		m Ω
$t_{d(on)}/t_r$	$V_{CC} = 1200\text{ V}$, $I_{Cnom} = 450\text{ A}$		290 / 90		ns
$t_{d(off)}/t_f$	$V_{GE} = \pm 15\text{ V}$		975 / 190		ns
$E_{on} (E_{off})$	$R_{Gon} = R_{Goff} = 3,6\text{ }\Omega$, $T_j = 125\text{ }^\circ\text{C}$		285 (170)		mJ
Inverse diode					
$V_F = V_{EC}$	$I_{Fnom} = 450\text{ A}$; $V_{GE} = 0\text{ V}$; $T_j = 25\text{ (125) }^\circ\text{C}$, chip level		1,7 (1,8)	2 (2,1)	V
$V_{(TO)}$	$T_j = 25\text{ (125) }^\circ\text{C}$		1,1 (0,9)	1,3 (1,1)	V
r_T	$T_j = 25\text{ (125) }^\circ\text{C}$		1,3 (2)	1,6 (2,2)	m Ω
I_{RRM}	$I_{Fnom} = 450\text{ A}$; $T_j = 25\text{ (125) }^\circ\text{C}$		(380)		A
Q_{rr}	$di/dt = 4200\text{ A}/\mu\text{s}$		(130)		μC
E_{rr}	$V_{GE} = -15\text{ V}$		(73)		mJ
Thermal characteristics					
$R_{th(j-c)}$	per IGBT			0,05	K/W
$R_{th(j-c)D}$	per Inverse Diode			0,11	K/W
$R_{th(j-c)FD}$	per FWD				K/W
$R_{th(c-s)}$	per module		0,04		K/W
Temperature sensor					
R_{25}	$T_c = 25\text{ }^\circ\text{C}$		5 $\pm$ 5%		k Ω
$B_{25/85}$	$R_2 = R_1 \exp[B(1/T_2 - 1/T_1)]$; $T[K]$; B		3420		K
Mechanical data					
M_s/M_t	to heatsink (M5) / for terminals (M6)	3/2,5		5 / 5	Nm
w			289		g



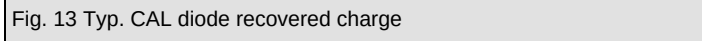
SEMiX 653GB176HDs



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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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